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PATENT NUMBER and ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	l .	SUBCLASS	GAU 2877		EXAMINER			
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**APPLICANT	S: Nishino	Sekiji; Ki 70 Z	shimoto Takes	2.86	3				
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** FOREIGN APPLICATIONS VERIFIED: JAPAN 2001-089735 03/27/2001 () JL									
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NOTICE OF ALLOWANCE MAILED			CLAIMS ALLOWED					
		Assistant Examiner	Total Claims		Print Claim for O.G			
ISSUE FEE			DRAWING					
Amount Due	Date Paid	7	Sheets Drwg.	Figs.Drwg.	Print Fig.			
		Primary Examiner	<u></u>					
TERMINAL		PREPARED FOR ISSUE	Application Examiner					
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